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		Results
<u>#1</u>	((master replication)<in>metadata)<AND>((first replica)<in>metadata)	0
<u>#2</u>	((first replica)<IN>metadata)	2
<u>#3</u>	((replication schema)<IN>metadata)	3
<u>#4</u>	((replication property)<IN>metadata)	4
<u>#5</u>	((first replica second replica)<IN>metadata)	0
<u>#6</u>	((first replica second replica)<IN>metadata)	0
<u>#7</u>	((first replica second replica)<IN>metadata)	0
<u>#8</u>	((replica and notification)<IN>metadata)	6

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